

Hideyuki Yasufuku

List of Publications by Year in descending order

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15
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96
citing authors

#	ARTICLE	IF	CITATIONS
1	Versailles Project on Advanced Materials and Standards interlaboratory study on intensity calibration for x-ray photoelectron spectroscopy instruments using low-density polyethylene. <i>Journal of Vacuum Science and Technology A: Vacuum, Surfaces and Films</i> , 2020, 38, 063208.	2.1	21
2	On the wide-energy-range tuning of x-ray photoemission electron microscope optics for the observation of the photoelectrons excited by several keV x-rays. <i>Review of Scientific Instruments</i> , 2006, 77, 033702.	1.3	5
3	Development of Photoemission Electron Microscope by Imaging Inner Shell Photoelectrons Excited by High Energy Synchrotron Radiation X-rays. <i>Hyomen Kagaku</i> , 2005, 26, 524-531.	0.0	1
4	Observation of Element-Specific Energy-Filtered X-Ray Photoemission Electron Microscopy Images of Au on Ta Using a Wien Filter Type Energy Analyzer. <i>Japanese Journal of Applied Physics</i> , 2004, 43, 7682-7688.	1.5	11
5	Application of x-ray photoemission electron microscopy developed at SPring-8 BL15XU. <i>Surface and Interface Analysis</i> , 2004, 36, 892-895.	1.8	9
6	Observation of Energy-filtered Images and Energy Dispersive Images of Au/Ta Photoelectron by EXPEEM with a Wien Filter Type Energy Analyzer. <i>Hyomen Kagaku</i> , 2003, 24, 509-511.	0.0	4
7	Observation of Energy-Filtered Image for X-Ray Photoemission Electron Microscopy (EXPEEM) Using a Retarding Wien-Filter Energy Analyzer. <i>Chemistry Letters</i> , 2002, 31, 842-843.	1.3	13
8	Recent Development and Application of LEEM/PEEM. Observations of Ultra-thin Organic Films by MEEM and PEEM.. <i>Hyomen Kagaku</i> , 2002, 23, 292-299.	0.0	1
9	PEEM and MEEM of chloroaluminum phthalocyanine ultrathin film on MoS ₂ . <i>Journal of Electron Spectroscopy and Related Phenomena</i> , 2001, 114-116, 1025-1030.	1.7	21
10	Surface Images of SiO ₂ /Si(100) Pattern using Electron Emission Microscopy with Metastable Atoms, Photons and Low-Energy Electrons. <i>Japanese Journal of Applied Physics</i> , 2001, 40, 2447-2450.	1.5	14
11	Diffusion of chloroaluminum phthalocyanine on MoS ₂ surface detected by photoemission electron microscopy and metastable electron emission microscopy. <i>Journal of Applied Physics</i> , 2001, 90, 213-216.	2.5	16
12	Surface States of Hydrogen-terminated Si(111) by Metastable Atom Electron Spectroscopy and Angle-resolved Ultraviolet Photoelectron Spectroscopy. <i>Japanese Journal of Applied Physics</i> , 2000, 39, 1706-1709.	1.5	11
13	Reaction at the Outermost Surface Selectively Induced by Metastable-Atom Beams. <i>Japanese Journal of Applied Physics</i> , 2000, 39, 4126-4129.	1.5	14
14	Study of solid surfaces by metastable electron emission microscopy: Energy-filtered images and local electron spectra at the outermost surface layer of silicon oxide on Si(100). <i>Journal of Applied Physics</i> , 1997, 82, 2954-2960.	2.5	34